

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/612,129	YEW ET AL.
	Examiner	Art Unit
	Phat X. Cao	2814

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	668	12/20/2005	PC
257	783	12/20/2005	PC
USPGPUB - text search (see print out)		12/20/2005	PC